

ID	R _{DS} (ON)(Typ)	VDSS	
16A	0.45Ω	650V	

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS16N65F	T0-220F	RS16N65F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25° C unless otherwise specified

Symbol	Parameter	RS16N65F	Units	
VDSS	Drain-to-Source Voltage	650	V	
ID	Continuous Drain Current TC=25℃ Continuous Drain Current TC=100℃	16 10	А	
IDM	Pulsed Drain Current (Note*1)	64		
PD	Power Dissipation	34	W	
VGS	Gate- to- Source Voltage	±30	V	
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	900	mJ	
	Maximum Temperature for Soldering			
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}$	
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150		

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS16N65F	Units	Test Conditions
RθJC	Junction-to-Case	3.7	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	52		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	650			V	VGS=0V,ID=250µA
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=650V,VGS=0 V
	Gate- to- Source Forward Leakage			100	- 4	VGS=30V,VDS=0V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS=0 V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.45	0.6	Ω	VGS=10V,ID=8A
VGS(TH)	Gate Threshold Voltage	2		4	V	VGS=VDS,ID=250µ A

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		37			
trise	Rise Time		50			VDS=310V
td(OFF)	Turn- OFF Delay Time		175		nS	ID=16A RG=24Ω
tfall	Fall Time		67			



Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		2742			VGS=0V
Coss	Output Capacitance		220		pF	VDS=25V
Crss	Reverse Transfer Capacitance		26			f=1.0MHz
Qg	Total Gate Charge		61			VDS=520V
Qgs	Gate- to- Source Charge		13		nC	ID=16A VGS=10V
Qgd	Gate-to-Drain(" Miller") Charge		23			

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

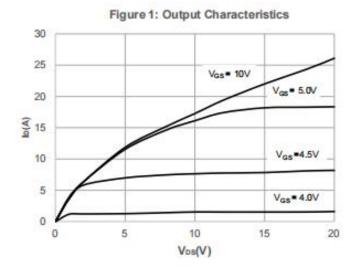
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			16	А	Integral pn- diode in
ISM	Maximum Pulsed Current			64	А	MOSFET
VSD	Diode Forward Voltage			1.2	V	IS=16A,VGS=0V
trr	Reverse Recovery Time		472		nS	VGS=0V.IS=16A,
Qrr	Reverse Recovery Charge		6.8		μC	di/dt=100A/µs

Notes:

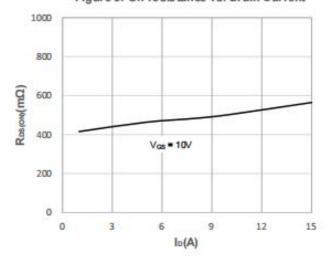
- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

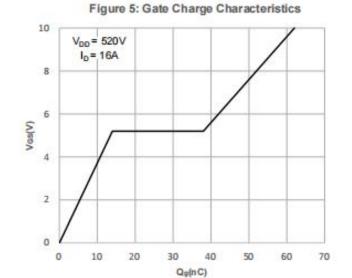


Typical Feature Curve









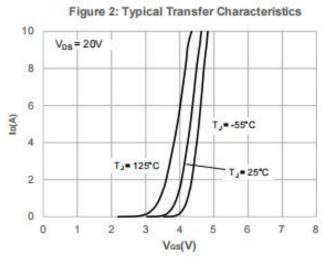
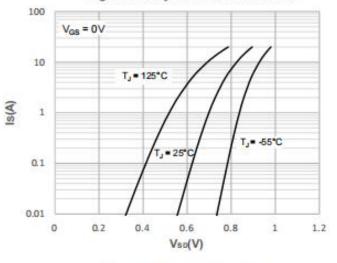
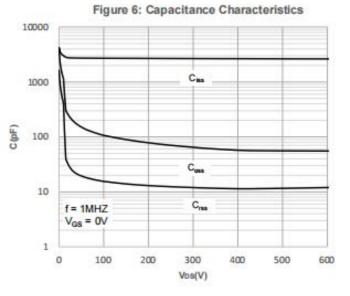


Figure 4: Body Diode Characteristics

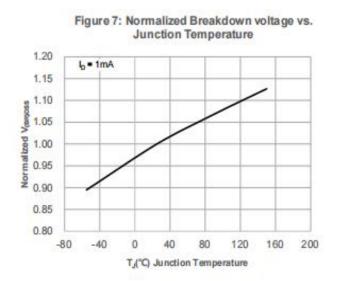


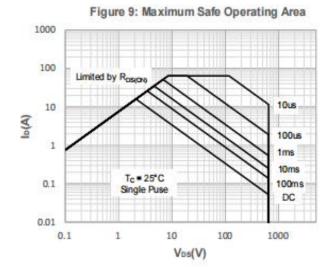


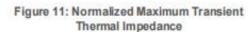
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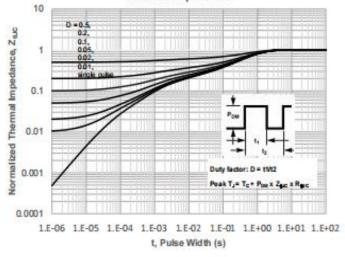


Typical Feature Curve









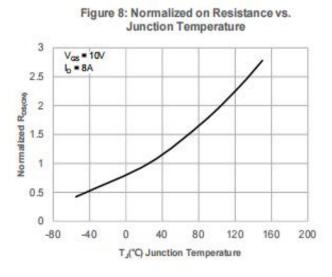
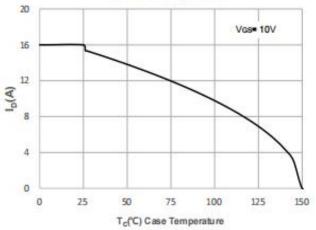
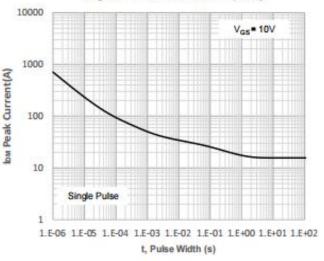


Figure 10: Maximum Continuous Drian Current vs. Case Temperature





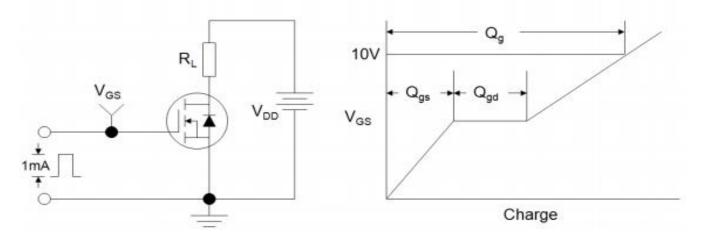


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Test Circuits and Waveforms







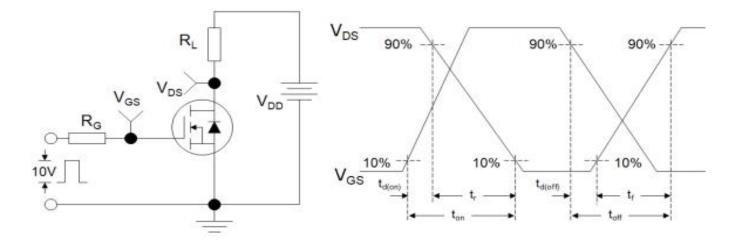
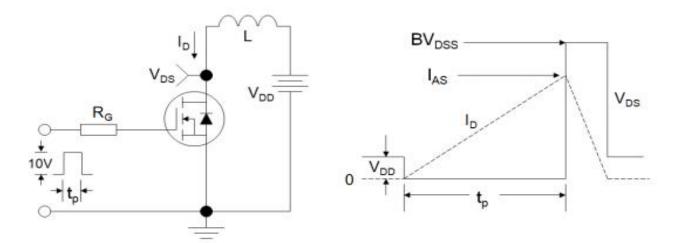


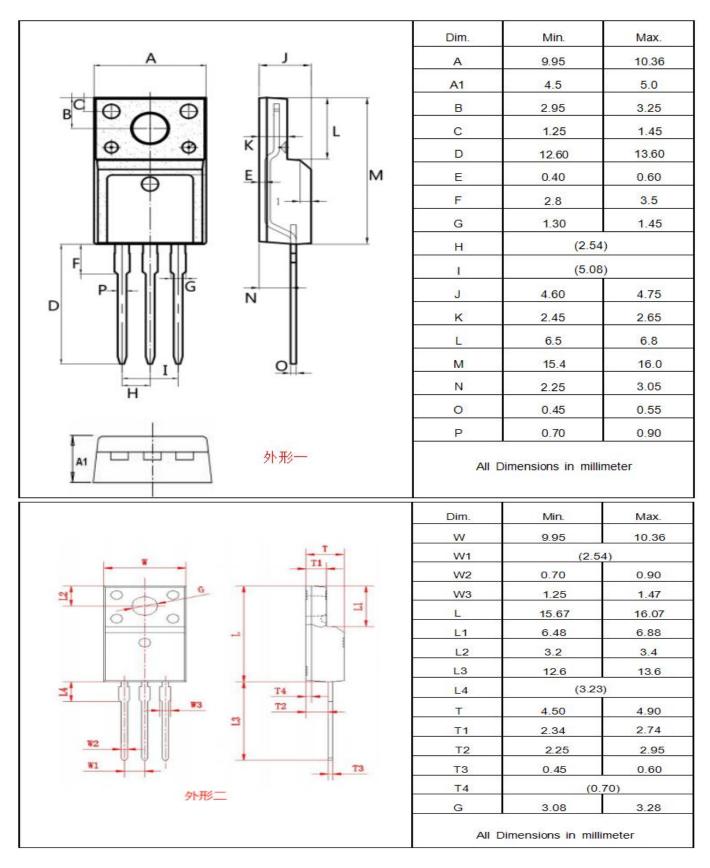
Figure Ct Unclamped Inductive Switching Test Circuit and Waveform



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Package outline drawing(TO-220F Unit: mm)





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